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| Notice of References Cited | Application/Control No. 10/643,606 | Applicant(s)/Patent Under Reexamination MATTERN ET AL. | |
| | Examiner Cachet I. Sellman | Art Unit 1762 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-2002/0071918 A1 | 06-2002 | Emch, Donaldson J. | 427/557 |
| * | B | US-2003/0031804 A1 | 02-2003 | Rekowski et al. | 427/557 |
| * | C | US-4,837,478 | 06-1989 | Anzai et al. | 313/112 |
| * | D | US-6,677,260 B2 | 01-2004 | Crane et al. | 501/64 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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